

FDS4895C

Dual N & P-Channel PowerTrench® MOSFET

General Description

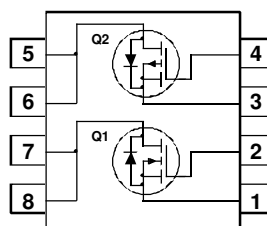
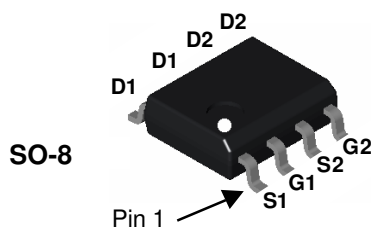
These dual N- and P-Channel enhancement mode power field effect transistors are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

Application

- Motor Control
- DC/DC conversion

Features

- **Q1:** N-Channel
5.5A, 40V $R_{DS(on)} = 39m\Omega @ V_{GS} = 10V$
 $R_{DS(on)} = 57m\Omega @ V_{GS} = 7V$
- **Q2:** P-Channel
-4.4A, -40V $R_{DS(on)} = 46m\Omega @ V_{GS} = -10V$
 $R_{DS(on)} = 63m\Omega @ V_{GS} = -4.5V$
- High power and handling capability in a widely used surface mount package



Absolute Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Q1	Q2	Units
V_{DSS}	Drain-Source Voltage	40	40	V
V_{GSS}	Gate-Source Voltage	± 20	± 20	V
I_D	Drain Current - Continuous (Note 1a)	5.5	-4.4	A
	- Pulsed	20	-20	
P_D	Power Dissipation for Dual Operation	2		W
	Power Dissipation for Single Operation (Note 1a)	1.6		
	(Note 1b)	1		
	(Note 1c)	0.9		
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150		$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	40	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS4895C	FDS4895C	13"	12mm	2500 units

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Off Characteristics							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$ $V_{GS} = 0\text{ V}, I_D = -250\ \mu\text{A}$	Q1 Q2	40 -40			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\ \mu\text{A}$, Referenced to 25°C $I_D = -250\ \mu\text{A}$, Referenced to 25°C	Q1 Q2		42 -40		mV/ $^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32\text{ V}, V_{GS} = 0\text{ V}$ $V_{DS} = -32\text{ V}, V_{GS} = 0\text{ V}$	Q1 Q2			1 -1	μA
I_{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$	All			100	nA
I_{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$	All			-100	nA
On Characteristics (Note 2)							
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$ $V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	Q1 Q2	2 -1	3.7 -1.7	5 -3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250\ \mu\text{A}$, Referenced to 25°C $I_D = -250\ \mu\text{A}$, Referenced to 25°C	Q1 Q2		-8 4		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 5.5\text{ A}$	Q1		32	39	m Ω
		$V_{GS} = 7\text{ V}, I_D = 4.8\text{ A}$			42	57	
		$V_{GS} = 10\text{ V}, I_D = 5.5\text{ A}, T_J = 125^\circ\text{C}$			49	64	
		$V_{GS} = -10\text{ V}, I_D = -4.4\text{ A}$ $V_{GS} = -4.5\text{ V}, I_D = -3.8\text{ A}$ $V_{GS} = -10\text{ V}, I_D = -4.4\text{ A}, T_J = 125^\circ\text{C}$	Q2		37 50 55	46 63 73	
g_{FS}	Forward Transconductance	$V_{DS} = 10\text{ V}, I_D = 5.5\text{ A}$	Q1		10		S
		$V_{DS} = -10\text{ V}, I_D = -4.4\text{ A}$	Q2		12		
Dynamic Characteristics							
C_{iss}	Input Capacitance	Q1 $V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}$	Q1		410		pF
			Q2		1050		
C_{oss}	Output Capacitance	Q2	Q1		97		pF
			Q2		140		
C_{rss}	Reverse Transfer Capacitance	$V_{DS} = -20\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}$	Q1		47		pF
			Q2		70		
R_G	Gate Resistance	$V_{GS} = 15\text{ mV}, f = 1.0\text{ MHz}$	Q1		2		Ω
			Q2		9		

Electrical Characteristics (continued) T_A = 25°C unless otherwise noted

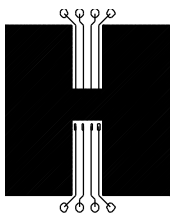
Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Switching Characteristics (Note 2)							
t _{d(on)}	Turn-On Delay Time	Q1 V _{DD} = 20 V, I _D = 1 A, V _{GS} = 10V, R _{GEN} = 6 Ω	Q1		9	18	ns
t _r	Turn-On Rise Time		Q2		12	22	ns
t _{d(off)}	Turn-Off Delay Time	Q2 V _{DD} = -20 V, I _D = -1 A, V _{GS} = -10V, R _{GEN} = 6 Ω	Q1		18	32	ns
t _f	Turn-Off Fall Time		Q2		45	72	ns
Q _g	Total Gate Charge	Q1 V _{DS} = 20 V, I _D = 5.5 A, V _{GS} = 10 V	Q1		7	10	nC
Q _{gs}	Gate-Source Charge		Q2		20	28	nC
Q _{gd}	Gate-Drain Charge	Q2 V _{DS} = -20 V, I _D = -4.4 A, V _{GS} = -10 V	Q1		2.4		nC
			Q2		3		nC
			Q1		2		nC
			Q2		4		nC

Drain-Source Diode Characteristics

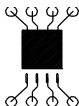
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.3 A (Note 2)	Q1		0.7	1.2	V
		V _{GS} = 0 V, I _S = -1.3 A (Note 2)	Q2		-0.7	-1.2	
t _{rr}	Diode Reverse Recovery Time	Q1 I _F = 5.5 A, d _F /d _t = 100 A/μs	Q1		21		nS
Q _{rr}	Diode Reverse Recovery Charge		Q2		24		nS
		Q2 I _F = -4.4 A, d _F /d _t = 100 A/μs	Q1		12		nC
			Q2		12		nC

Notes:

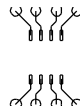
1. R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.



a) 78°/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125°/W when mounted on a .02 in² pad of 2 oz copper



c) 135°/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

Typical Characteristics: Q1 (N-Channel)

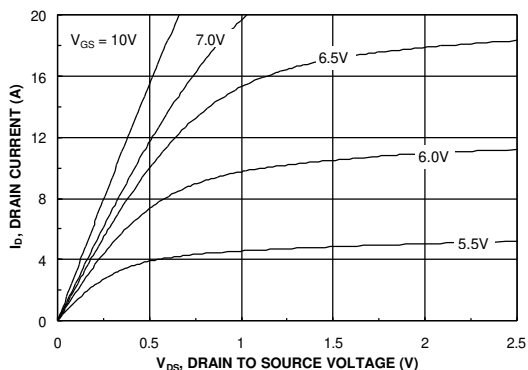


Figure 1. On-Region Characteristics.

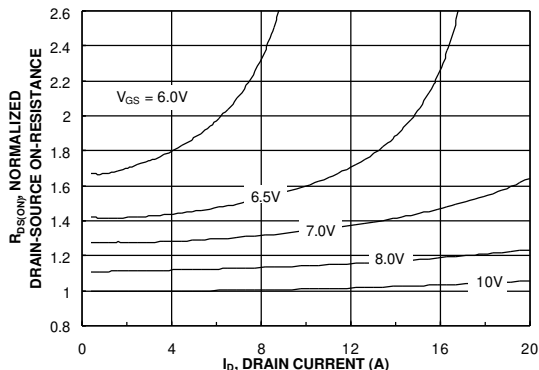


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

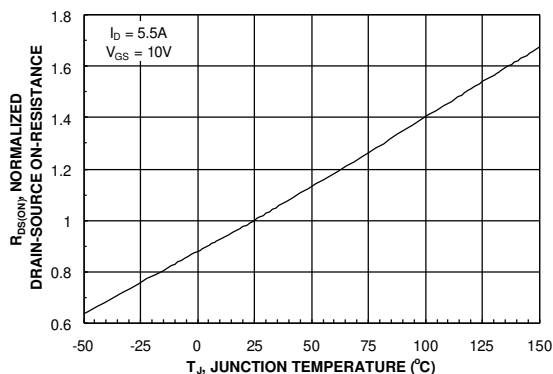


Figure 3. On-Resistance Variation with Temperature.

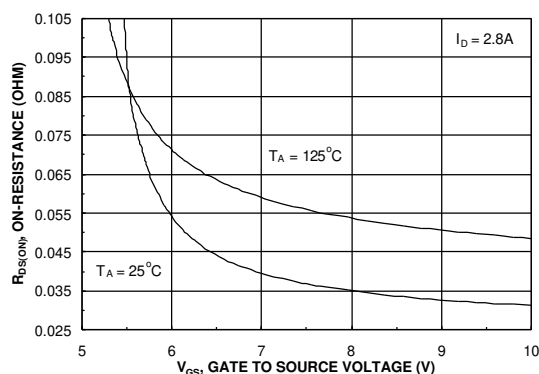


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

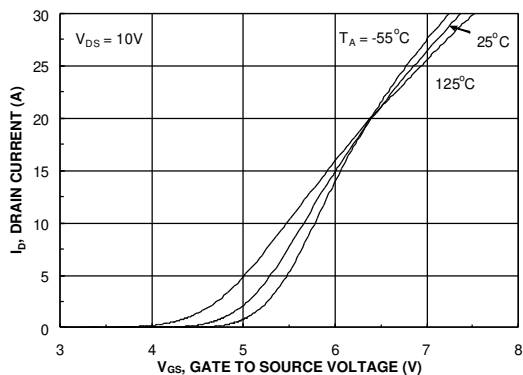


Figure 5. Transfer Characteristics.

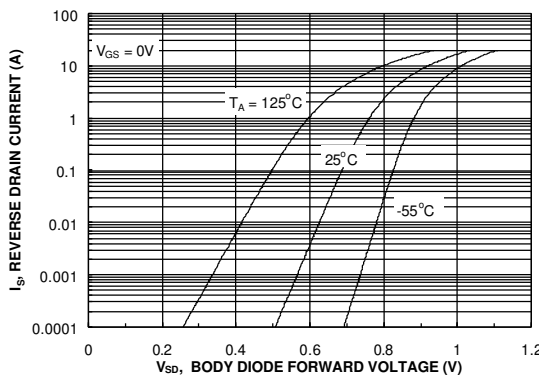


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q1 (N-Channel)

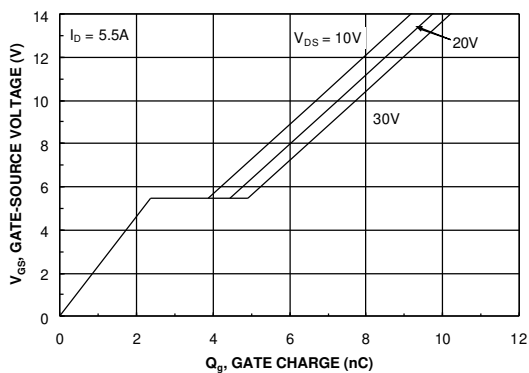


Figure 7. Gate Charge Characteristics.

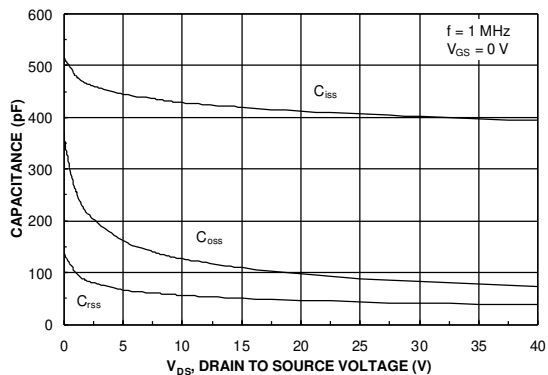


Figure 8. Capacitance Characteristics.

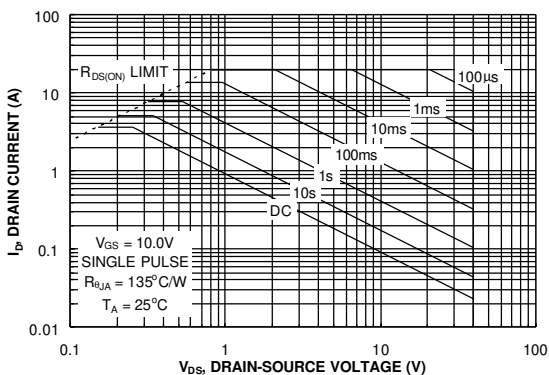


Figure 9. Maximum Safe Operating Area.

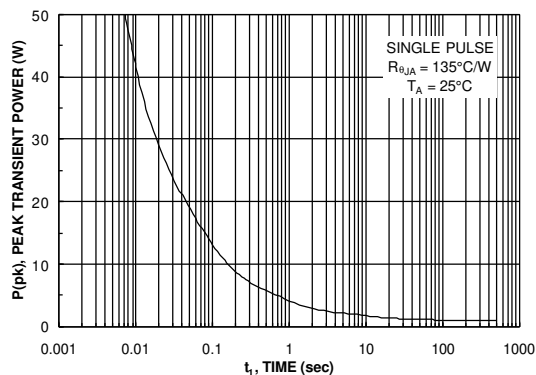


Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics: Q2 (P-Channel)

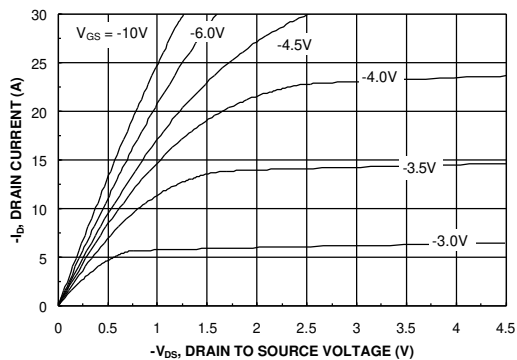


Figure 11. On-Region Characteristics.

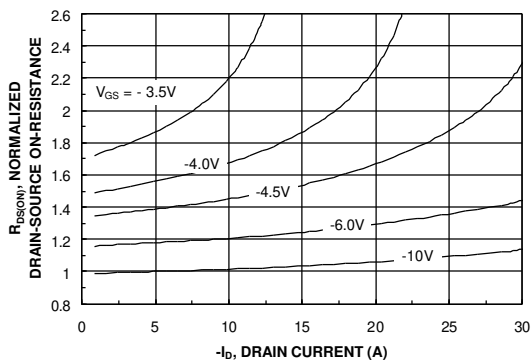


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

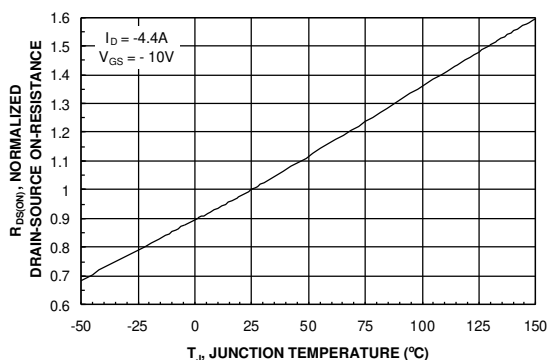


Figure 13. On-Resistance Variation with Temperature.

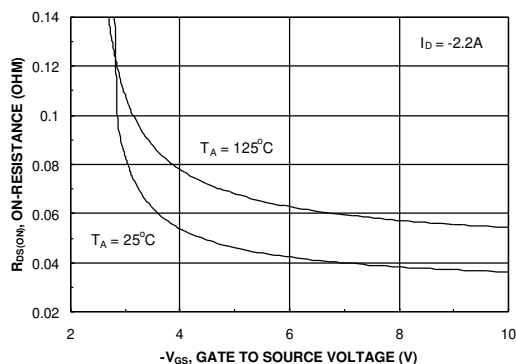


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

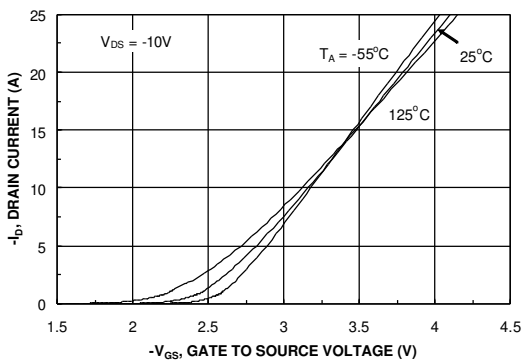


Figure 15. Transfer Characteristics.

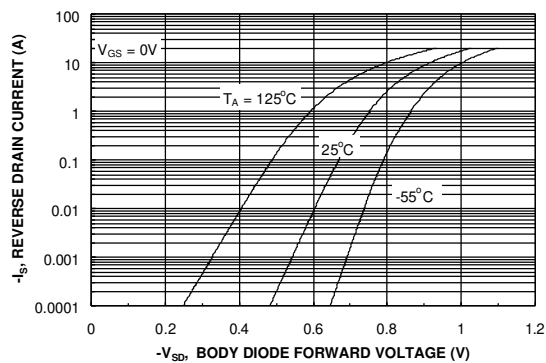


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q2 (P-Channel)

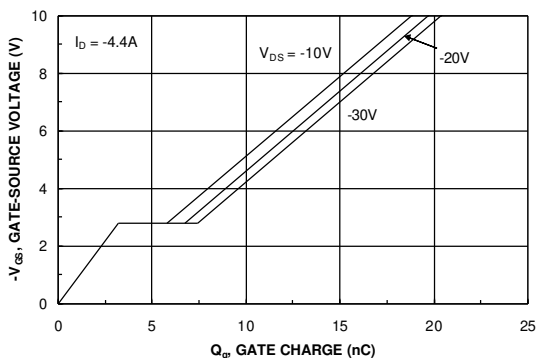


Figure 17. Gate Charge Characteristics.

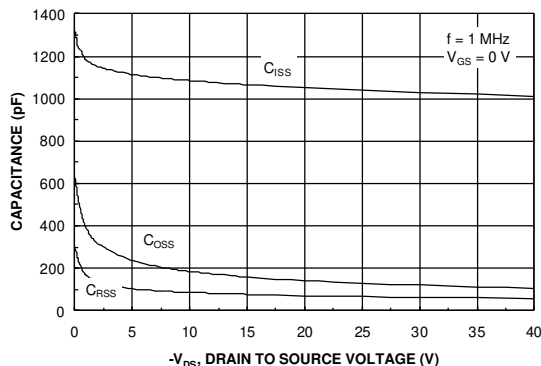


Figure 18. Capacitance Characteristics.

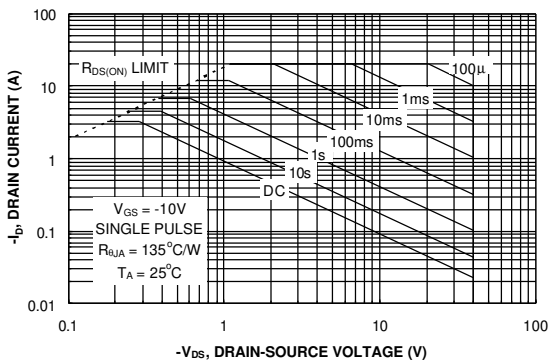


Figure 19. Maximum Safe Operating Area.

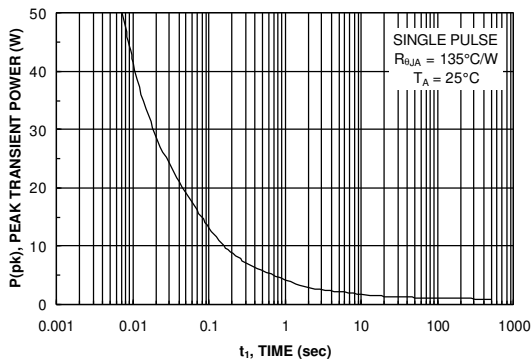


Figure 20. Single Pulse Maximum Power Dissipation.

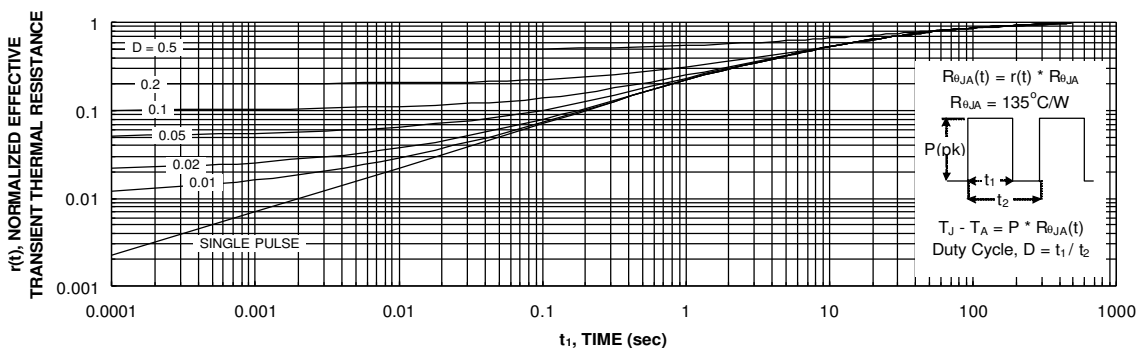


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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